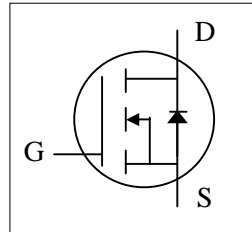




- ▼ Simple Drive Requirement
- ▼ Lower On-resistance
- ▼ Fast Switching Characteristic

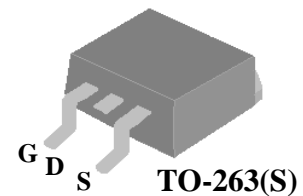
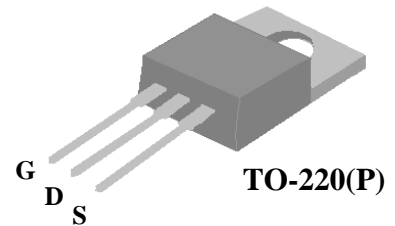


BV_{DSS}	100V
$R_{DS(ON)}$	18mΩ
I_D	67A

Description

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-263 package is widely preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters. The through-hole version (AP60T10GP) are available for low-profile applications.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	+20	V
$I_D@T_C=25^\circ C$	Continuous Drain Current, V_{GS} @ 10V	67	A
$I_D@T_C=100^\circ C$	Continuous Drain Current, V_{GS} @ 10V	42	A
I_{DM}	Pulsed Drain Current ¹	250	A
$P_D@T_C=25^\circ C$	Total Power Dissipation	167	W
E_{AS}	Single Pulse Avalanche Energy ³	288	mJ
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Value	Units
Rthj-c	Maximum Thermal Resistance, Junction-case	0.75	°C/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient (PCB mount) ⁴	40	°C/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient	62	°C/W



AP60T10GS/P

Electrical Characteristics @T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	100	-	-	V
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =28A	-	-	18	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	2	-	5	V
g _{fs}	Forward Transconductance	V _{DS} =25V, I _D =28A	-	45	-	S
I _{DSS}	Drain-Source Leakage Current	V _{DS} =80V, V _{GS} =0V	-	-	25	uA
I _{GSS}	Gate-Source Leakage	V _{GS} = +20V, V _{DS} =0V	-	-	±100	nA
Q _g	Total Gate Charge ²	I _D =28A	-	55	90	nC
Q _{gs}	Gate-Source Charge	V _{DS} =80V	-	15	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =10V	-	24	-	nC
t _{d(on)}	Turn-on Delay Time ²	V _{DS} =50V	-	16	-	ns
t _r	Rise Time	I _D =28A	-	68	-	ns
t _{d(off)}	Turn-off Delay Time	R _G =2.5Ω, V _{GS} =10V	-	29	-	ns
t _f	Fall Time	R _D =1.8Ω	-	42	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	2800	4500	pF
C _{oss}	Output Capacitance	V _{DS} =25V	-	400	-	pF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	155	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =28A, V _{GS} =0V	-	-	1.3	V
t _{rr}	Reverse Recovery Time ²	I _S =28A, V _{GS} =0V	-	80	-	ns
Q _{rr}	Reverse Recovery Charge	di/dt=100A/μs	-	270	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Starting T_j=25°C , V_{DD}=50V , L=1mH , R_G=25Ω , I_{AS}=24A.
- 4.Surface mounted on 1 in² copper pad of FR4 board

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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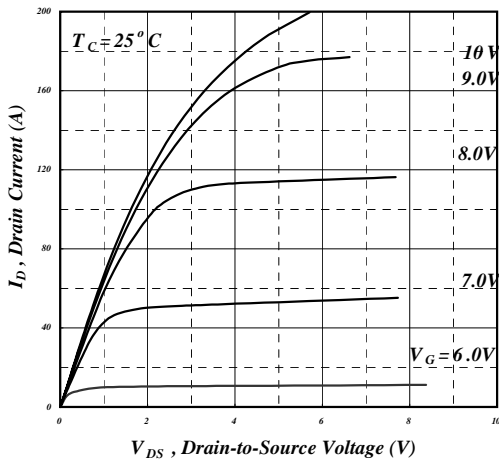


Fig 1. Typical Output Characteristics

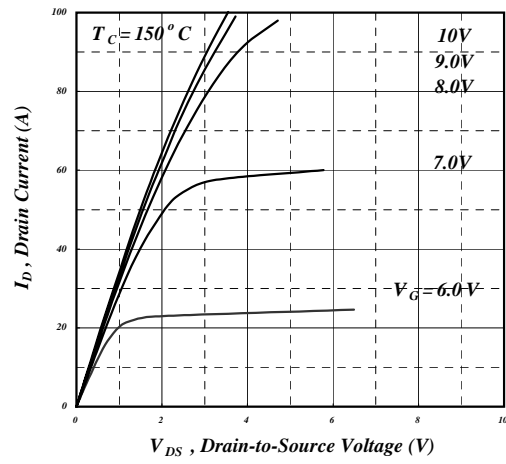


Fig 2. Typical Output Characteristics

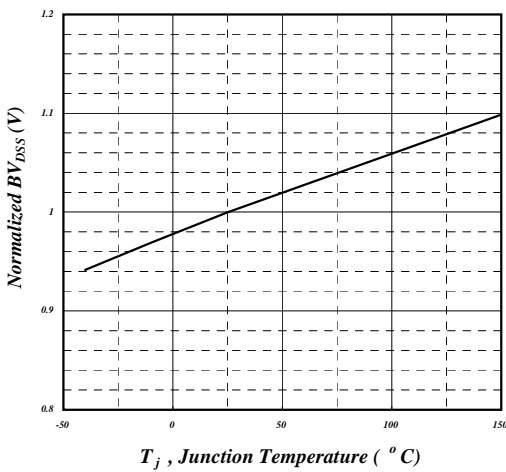


Fig 3. Normalized BV_{DSS} v.s. Junction Temperature

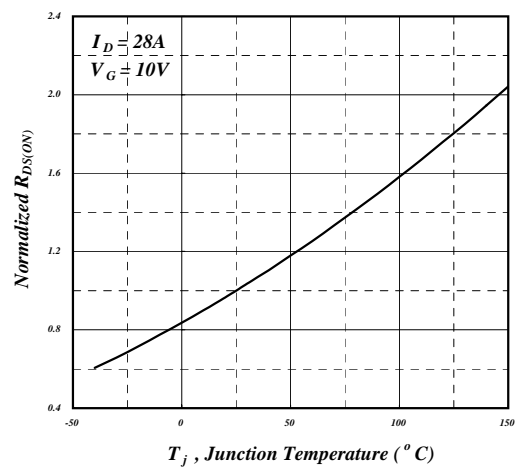


Fig 4. Normalized On-Resistance v.s. Junction Temperature

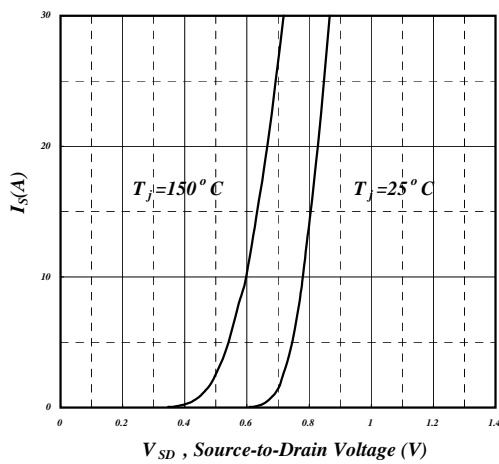


Fig 5. Forward Characteristic of Reverse Diode

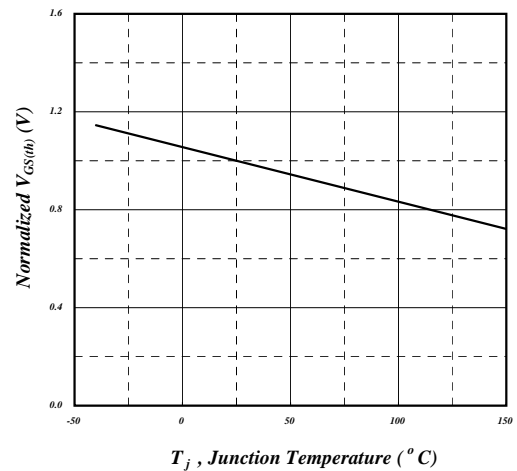


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

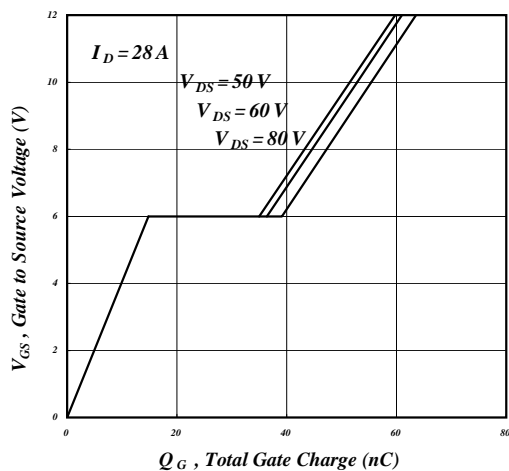


Fig 7. Gate Charge Characteristics

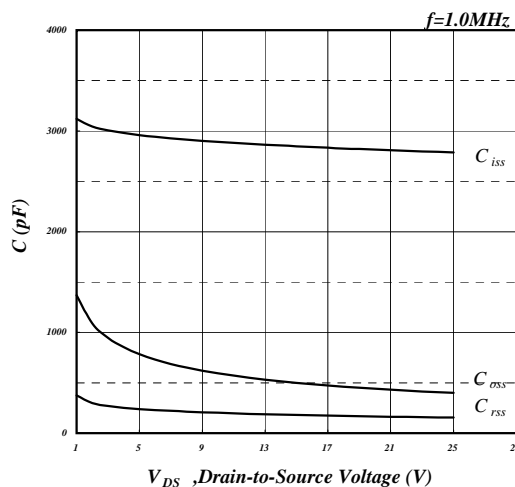


Fig 8. Typical Capacitance Characteristics

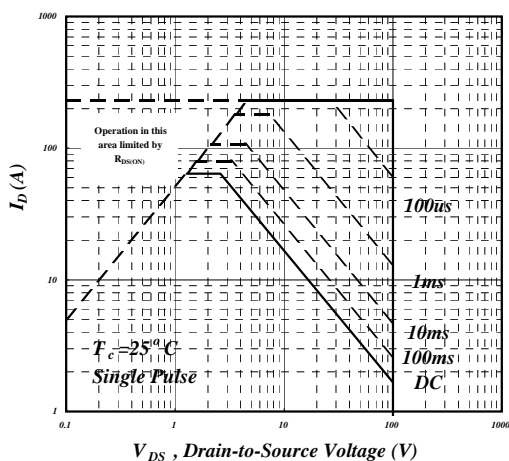


Fig 9. Maximum Safe Operating Area

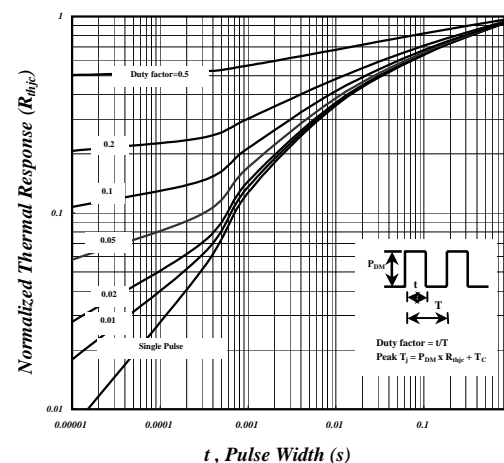


Fig 10. Effective Transient Thermal Impedance

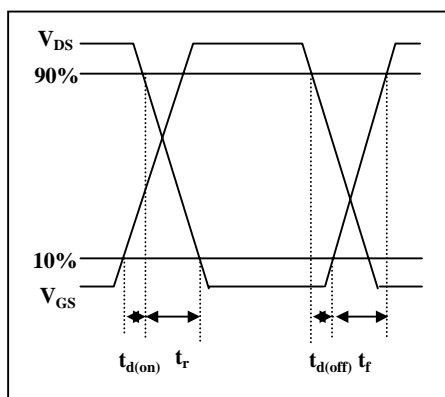


Fig 11. Switching Time Waveform

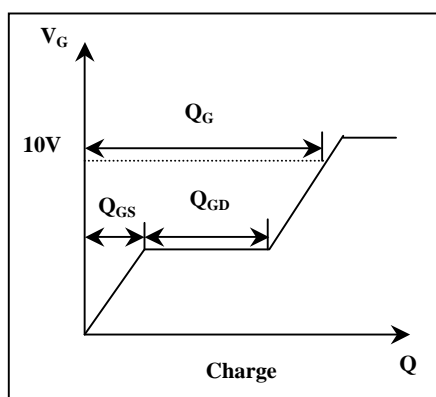


Fig 12. Gate Charge Waveform